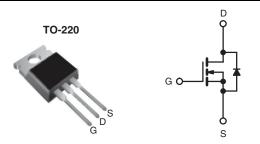


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	1000			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	11		
Q _g (Max.) (nC)	38			
Q _{gs} (nC)	4.9			
Q _{gd} (nC)	22			
Configuration	Single			



N-Channel MOSFET

FEATURES

- Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effictiveness.

The TO-220 package is universially preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220
Lead (Pb)-free	IRFBG20PbF
Lead (Fb)-liee	SiHFBG20-E3
SnPb	IRFBG20
	SiHFBG20

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	1000	V	
Gate-Source Voltage			V_{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	- I _D	1.4		
	VGS at 10 V	T _C = 100 °C		0.86	Α	
Pulsed Drain Current ^a			I _{DM}	5.6		
Linear Derating Factor				0.43	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	200	mJ	
Repetitive Avalanche Currenta			I _{AR}	1.4	Α	
Repetitive Avalanche Energy ^a			E _{AR}	5.4	mJ	
Maximum Power Dissipation	T _C =	25 °C	P _D	54	W	
Peak Diode Recovery dV/dt ^c			dV/dt	1.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	00	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	- °C	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 193 \,\mu\text{H}$, $R_G = 25 \,\Omega$, $I_{AS} = 1.4 \,\text{A}$ (see fig. 12).
- c. $I_{SD} \le 1.4$ A, $dI/dt \le 60$ A/µs, $V_{DD} \le 600$, $T_{J} \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFBG20, SiHFBG20

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.3		

SPECIFICATIONS T _J = 25 °C, PARAMETER	SYMBOL	TEC	MIN.	TYP.	MAX.	UNIT	
Static	O T IVIDOL	120	T CONDITIONS	IVIII4.		WAX.	Olviii
Drain-Source Breakdown Voltage	V _{DS}	Voc	1000	l _	T _	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$		= 0 V, I _D = 250 μA te to 25 °C, I _D = 1 mA	-	1.2		V/°C
Gate-Source Threshold Voltage	V _{GS(th)}		V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 \text{ V}$	-	_	± 100	nA
date course countage	·G55		V _{GS} = 120 V V _{DS} = 1000 V, V _{GS} = 0 V V _{DS} = 800 V, V _{GS} = 0 V, T _J = 125 °C		_	100	μΑ
Zero Gate Voltage Drain Current	I_{DSS}				-	500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		-	-	11	Ω
Forward Transconductance	9fs	V _{DS} =	50 V, I _D = 0.84 A ^b	1.0	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	500	-	
Output Capacitance	C _{oss}			-	52	-	pF
Reverse Transfer Capacitance	C _{rss}			-	17	-	
Total Gate Charge	Qg	V _{GS} = 10 V	I _D = 1.4 A, V _{DS} = 400 V, see fig. 6 and 13 ^b	-	-	38	nC
Gate-Source Charge	Q _{gs}			-	-	4.9	
Gate-Drain Charge	Q_{gd}			-	-	22	
Turn-On Delay Time	$t_{d(on)}$			-	9.4	-	- ns
Rise Time	t _r	V _{DD} =	V_{DD} = 500 V, I_D = 1.4 A, R_G = 18 Ω , R_D = 370 Ω , see fig. 10 ^b		17	-	
Turn-Off Delay Time	t _{d(off)}	$R_G = 18 \Omega$,			58	-	
Fall Time	t _f			-	31	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.4	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	5.6	A
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 1.4 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 1.4 A, dl/dt = 100 A/μs ^b		-	130	190	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.46	0.69	μС
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				_D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

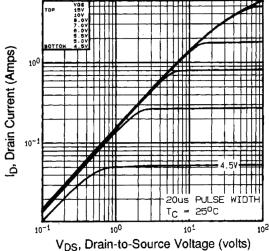


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

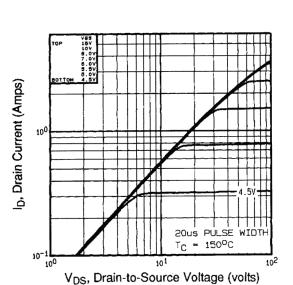


Fig. 2 -Typical Output Characteristics, $T_C = 150 \, ^{\circ}C$

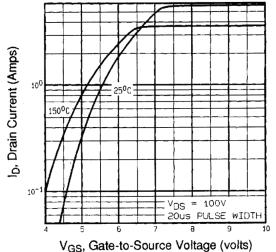


Fig. 3 - Typical Transfer Characteristics

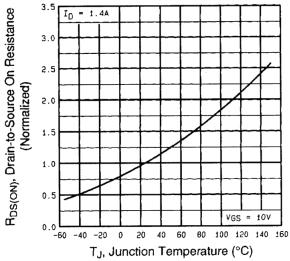


Fig. 4 - Normalized On-Resistance vs. Temperature

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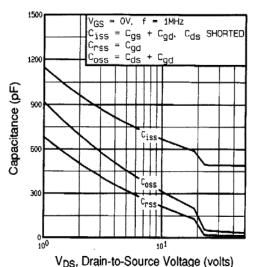


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

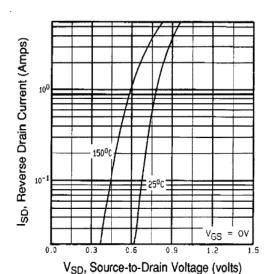


Fig. 7 - Typical Source-Drain Diode Forward Voltage

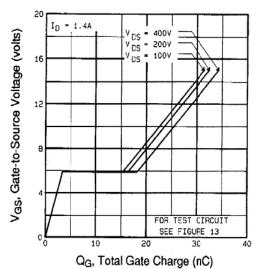


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

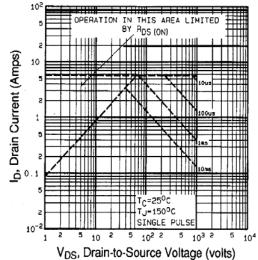


Fig. 8 - Maximum Safe Operating Area





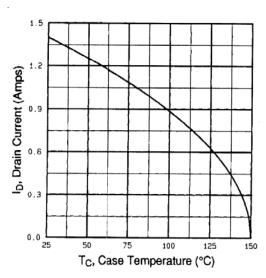


Fig. 9 - Maximum Drain Current vs. Case Temperature

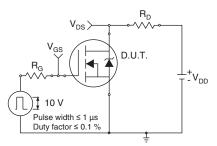


Fig. 10a - Switching Time Test Circuit

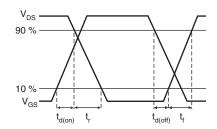


Fig. 10b - Switching Time Waveforms

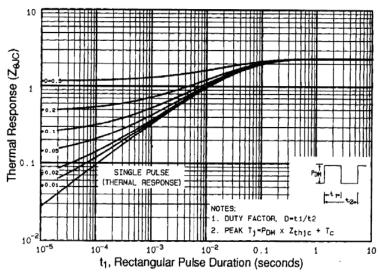


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

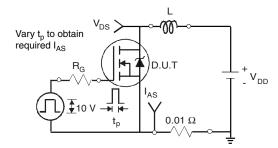


Fig. 12a - Unclamped Inductive Test Circuit

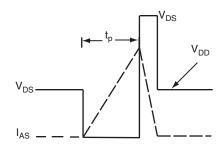


Fig. 12b - Unclamped Inductive Waveforms

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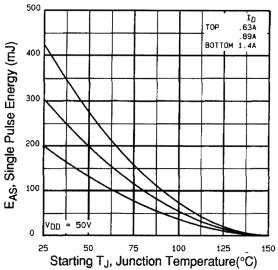


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

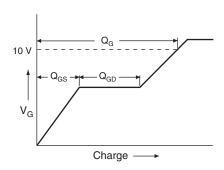


Fig. 13a - Basic Gate Charge Waveform

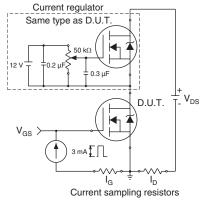
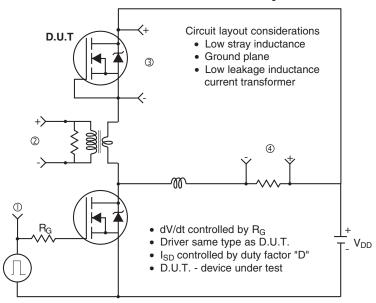


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



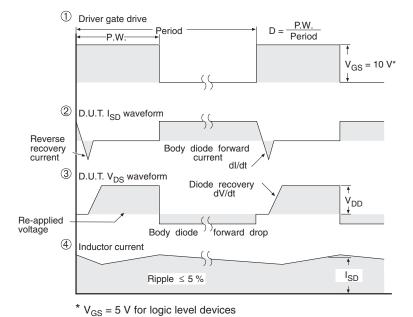


Fig. 14 -For N-Channel

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